

MBN2400E17F

Target Specification

Silicon N-channel IGBT 1700V F version

FEATURES

- * Soft switching behavior & low conduction loss:
Soft low-injection punch-through with trench gate IGBT.
- * Low driving power:
Low input capacitance advanced trench gate.
- * Ultra soft fast recovery diode.

ABSOLUTE MAXIMUM RATINGS (T_C=25°C)

Item	Symbol	Unit	MBN2400E17F
Collector Emitter Voltage	V _{CES}	V	1,700
Gate Emitter Voltage	V _{GES}	V	±20
Collector Current	DC	I _C	2,400
	1ms	I _{Cp}	4,800
Forward Current	DC	I _F	2,400
	1ms	I _{FM}	4,800
Junction Temperature	T _{j op}	°C	-40 ~ +150
Storage Temperature	T _{stg}	°C	-40 ~ +125
Isolation Voltage	V _{ISO}	V _{RMS}	4,000(AC 1 minute)
Screw Torque	Terminals (M4/M8)	-	2/15 (1)
	Mounting (M6)	-	6 (2)

Notes: (1) Recommended Value $1.8 \pm 0.2/15^{+0}_{-3}$ N·m (2) Recommended Value 5.5 ± 0.5 N·m

ELECTRICAL CHARACTERISTICS

Item	Symbol	Unit	Min.	Typ.	Max.	Test Conditions	
Collector Emitter Cut-Off Current	I _{CES}	mA	-	3	50	V _{CE} =1,700V, V _{GE} =0V, T _j =125°C	
			-	30	-	V _{CE} =1,700V, V _{GE} =0V, T _j =150°C	
Gate Emitter Leakage Current	I _{GES}	nA	-500	-	+500	V _{GE} =±20V, V _{CE} =0V, T _j =25°C	
Collector Emitter Saturation Voltage	V _{CE(sat)}	V	TBD	2.0	TBD	I _C =2,400A, V _{GE} =15V, T _j =25°C	
			-	2.4	-	I _C =2,400A, V _{GE} =15V, T _j =150°C	
Gate Emitter Threshold Voltage	V _{GE(TO)}	V	4.1	5.5	7.1	V _{CE} =10V, I _C =240mA, T _j =25°C	
Input Capacitance	C _{ies}	nF	-	130	-	V _{CE} =10V, V _{GE} =0V, f=100kHz, T _j =25°C	
Internal Gate Resistance	R _{ge}	Ω	-	1.8	-	V _{CE} =10V, V _{GE} =0V, f=100kHz, T _j =25°C	
Switching Times	Rise Time	t _r	TBD	0.7	TBD	V _{CC} =900V, I _C =2,400A L _s =55nH (3) R _G (on/off)=2.7/2.7Ω (3) V _{GE} =±15V, T _j =150°C	
	Turn On Time	t _{on}	TBD	1.55	TBD		
	Fall Time	t _f	TBD	1.4	TBD		
	Turn Off Time	t _{off}	TBD	3.2	TBD		
Peak Forward Voltage Drop	V _{FM}	V	TBD	1.8	TBD	I _F =2,400A, V _{GE} =0V, T _j =25°C	
			-	2.25	-	I _F =2,400A, V _{GE} =0V, T _j =150°C	
Reverse Recovery Time	t _{rr}	μs	TBD	0.65	-	V _{CC} =900V, I _C =2,400A L _s =55nH (3) R _G (on/off)=2.7/2.7Ω (3) V _{GE} =±15V, T _j =150°C	
Turn On Loss	E _{on(10%)}	J/P	-	0.90	-		
	E _{on(full)}	J/P	TBD	1.20	TBD		
Turn Off Loss	E _{off(10%)}	J/P	-	1.60	-		
	E _{off(full)}	J/P	TBD	1.90	TBD		
Reverse Recovery Loss	E _{rr(10%)}	J/P	-	0.90	-		
	E _{rr(full)}	J/P	TBD	1.10	TBD		
Stray inductance in module	L _{SCE}	nH	-	12	-		
Thermal Impedance	IGBT	R _{th(j-c)}	K/W	-	-	0.010	Junction to case
	FWD	R _{th(j-c)}	K/W	-	-	0.015	
Contact Thermal Impedance		R _{th(c-f)}	K/W	-	0.005	-	Case to fin (λ _{grease} =1W/(m·K), heat-sink flatness ≤50μm)

Notes:(3) L_s and R_G are the test condition's values for evaluation of the switching times, not recommended value.

Please, determine the suitable R_G value after the measurement of switching waveforms (overshoot voltage, etc.) with appliance mounted.

- * Please contact our representatives at order.
- * For improvement, specifications are subject to change without notice.
- * For actual application, please confirm this spec sheet is the newest revision.

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DEFINITION OF TEST CIRCUIT

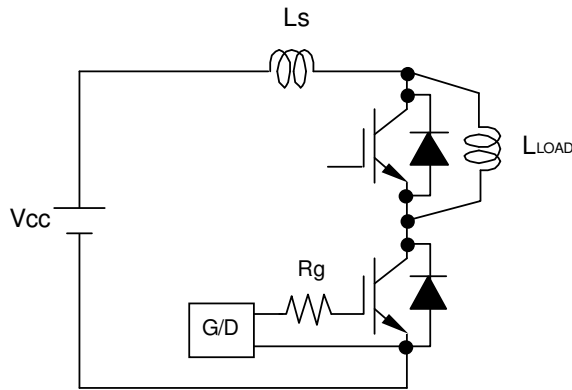


Fig.1 Switching test circuit

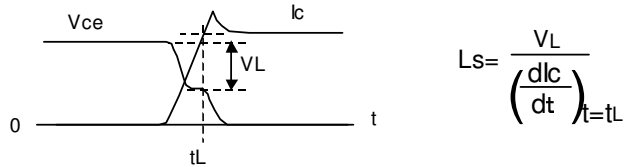


Fig.2 Definition of Ls

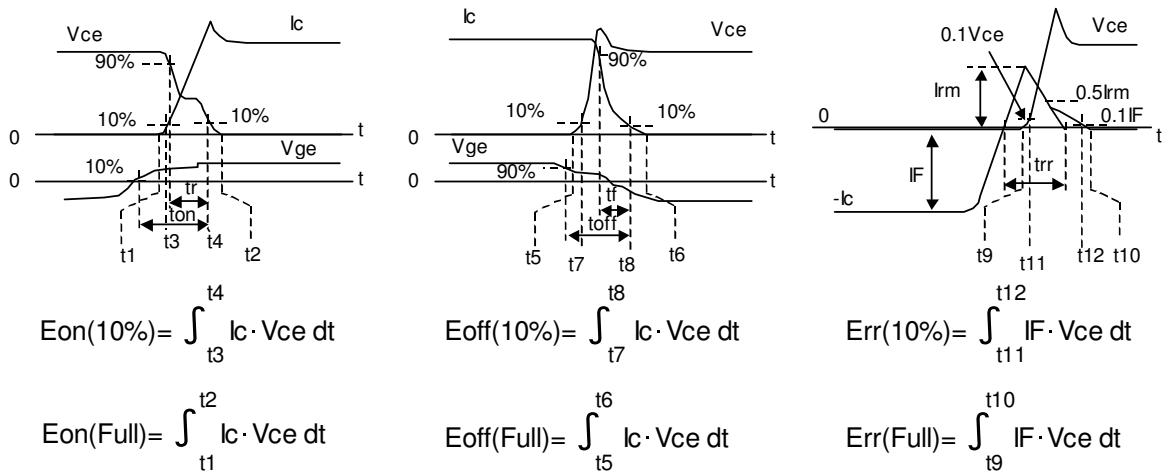


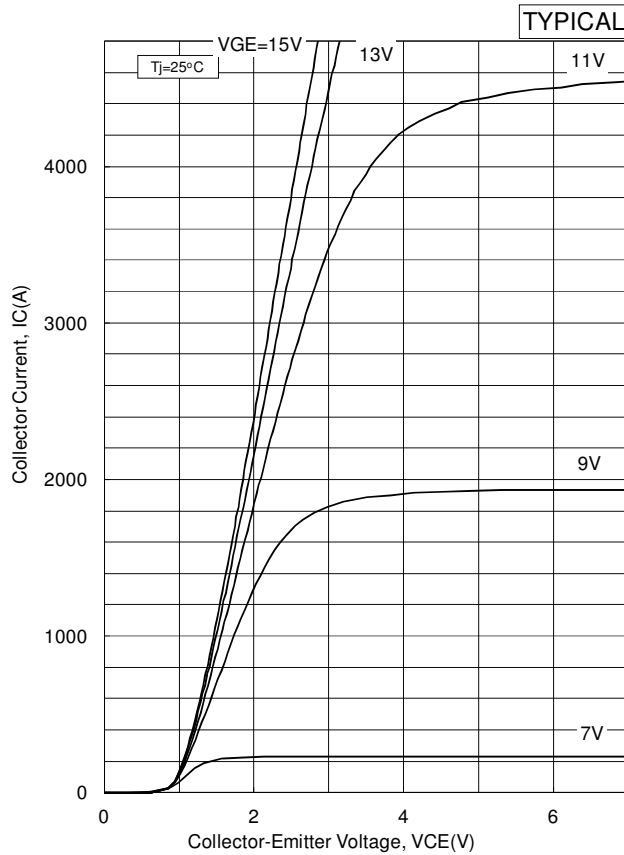
Fig.3 Definition of switching loss

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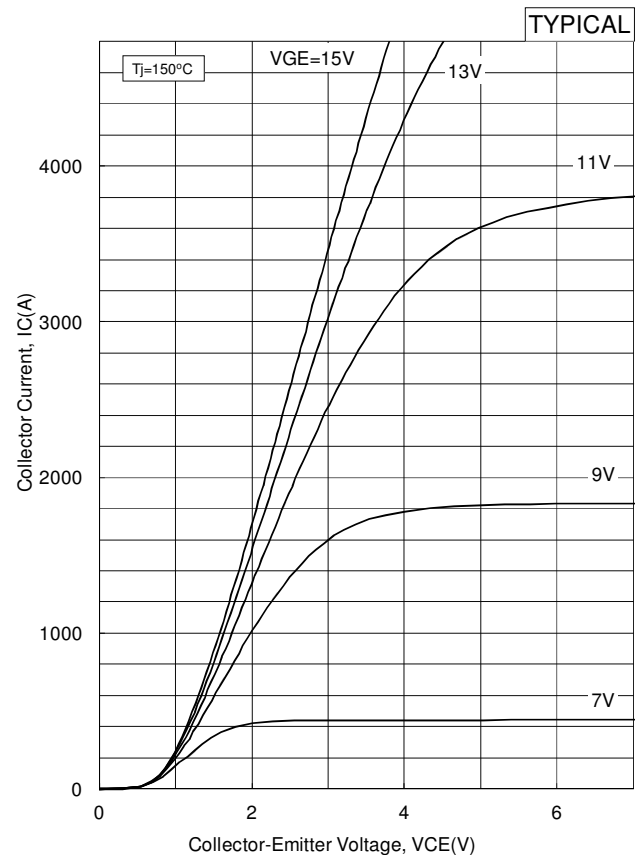
Target Specification

CHARACTERISTICS CURVE

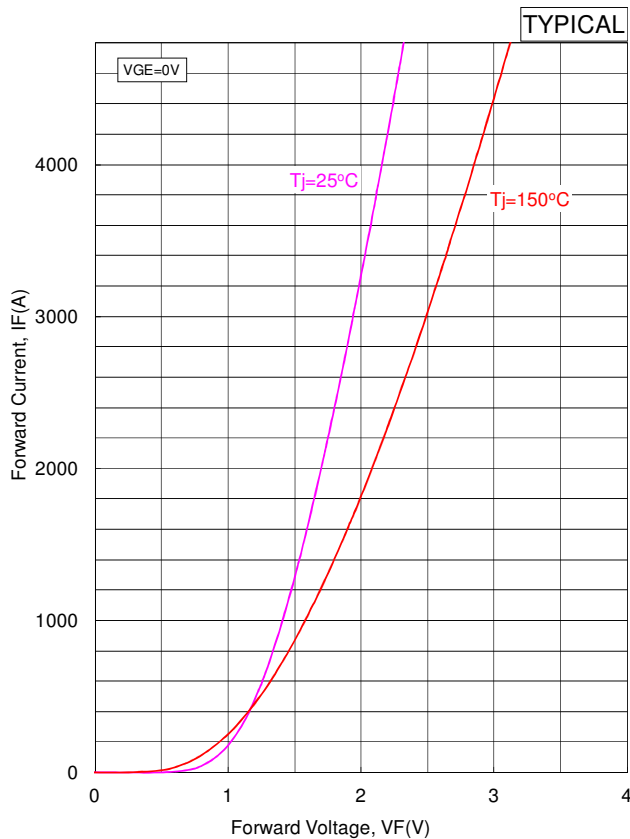
STATIC CHARACTERISTICS



Collector Current vs. Collector to Emitter Voltage



Collector Current vs. Collector to Emitter Voltage

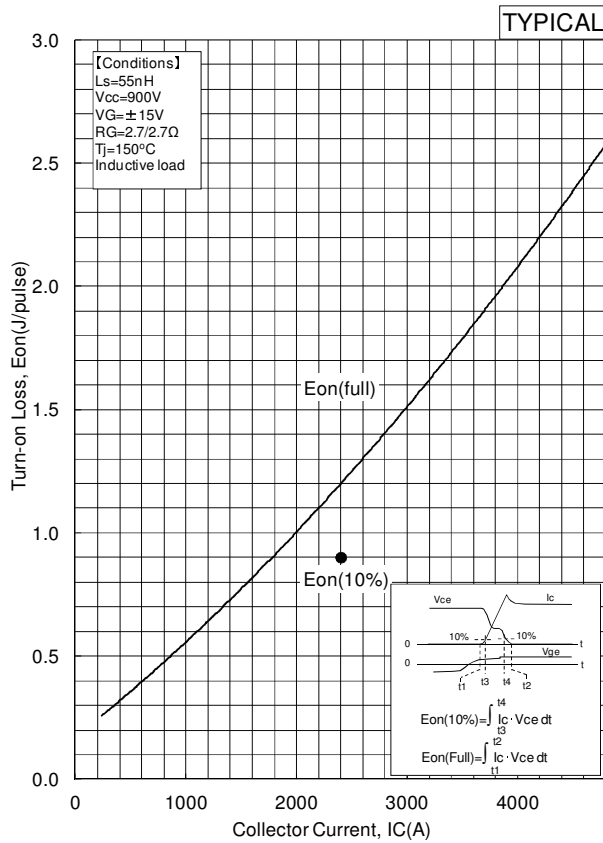


Forward Voltage of free-wheeling diode

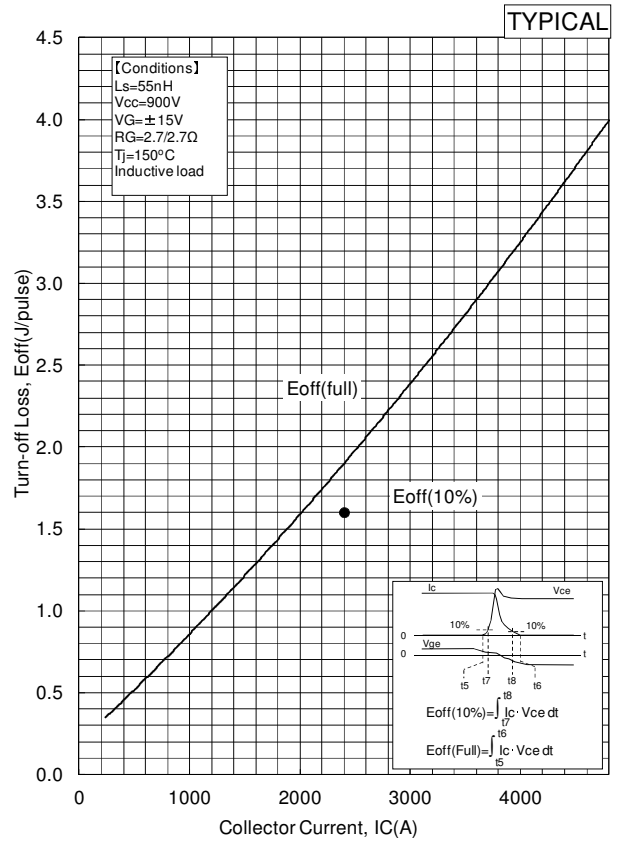
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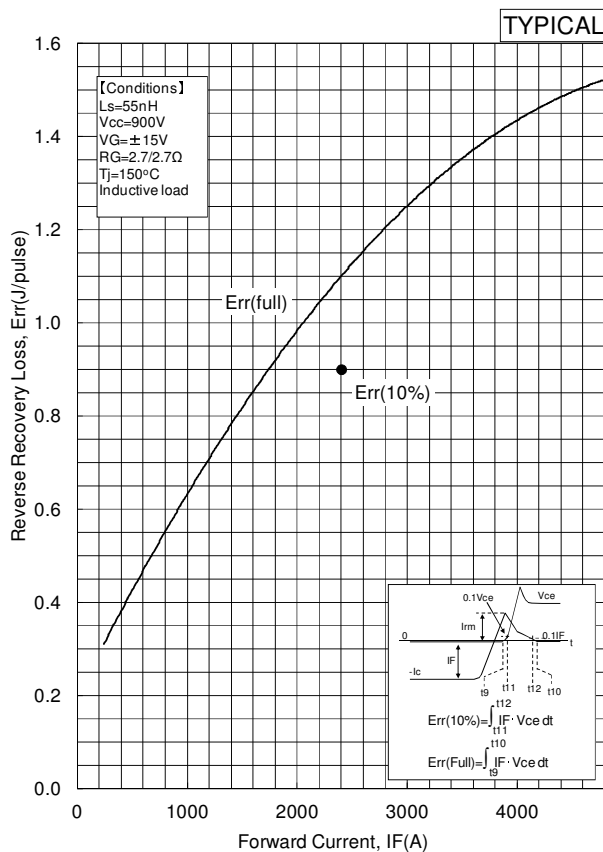
DYNAMIC CHARACTERISTICS



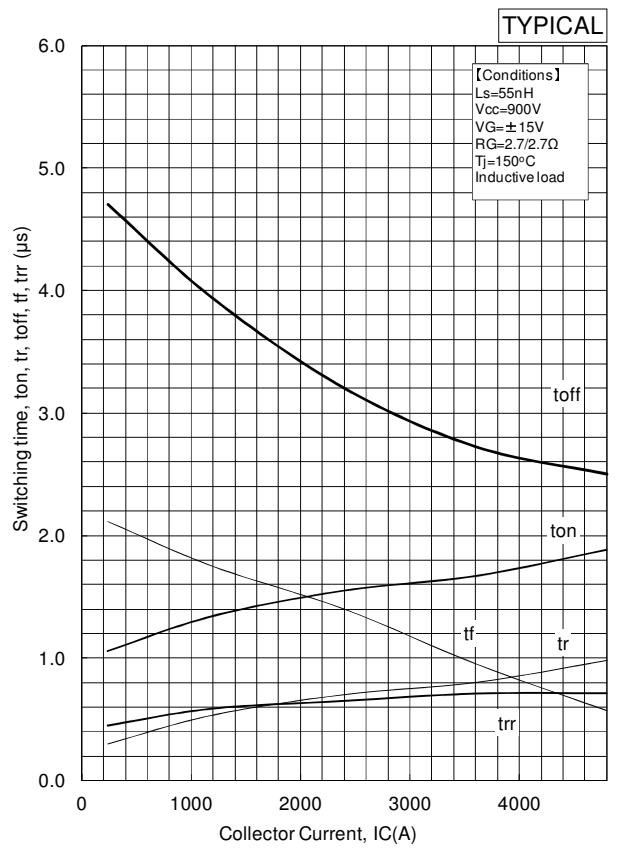
Turn-on Loss vs. Collector Current



Turn-off Loss vs. Collector Current



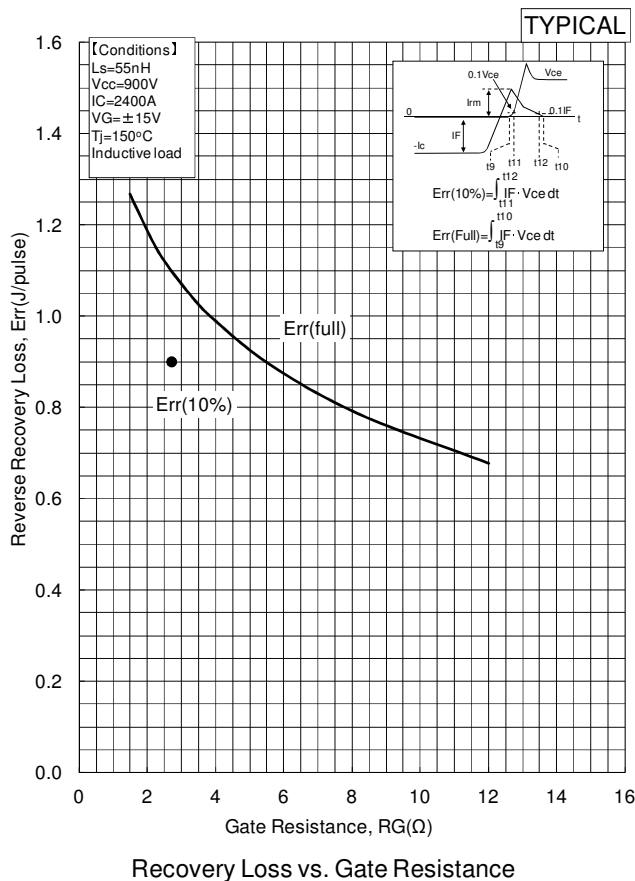
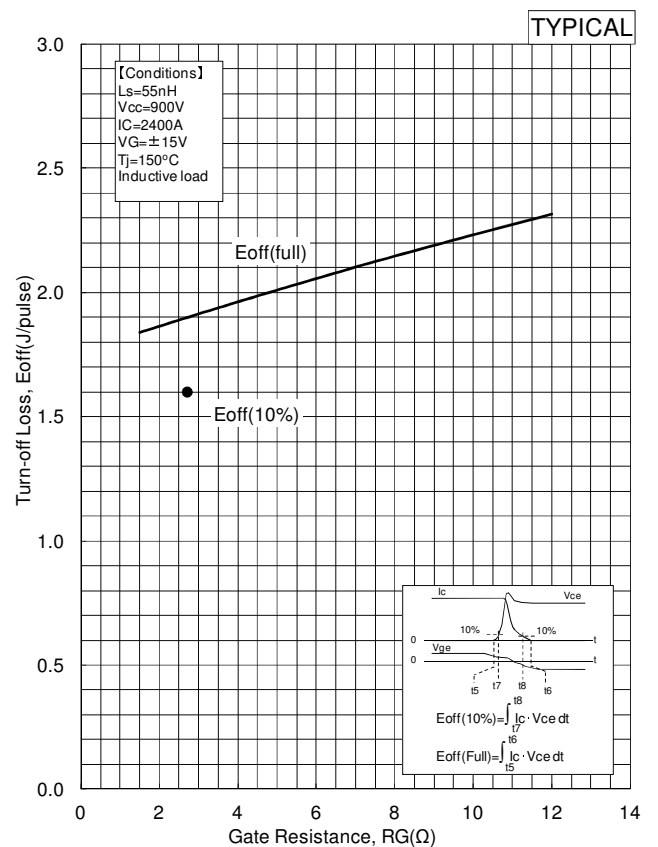
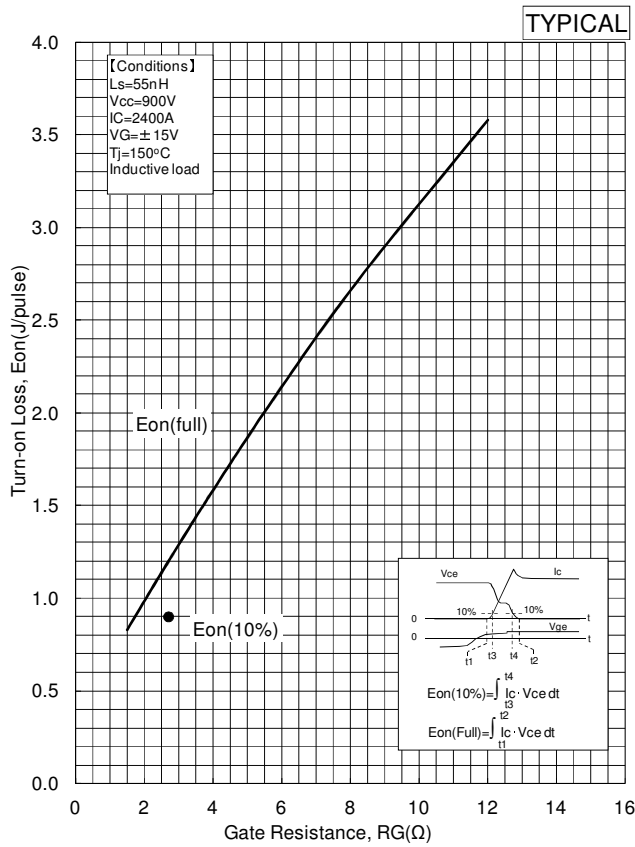
Recovery Loss vs. Forward Current



Switching time vs. Collector current

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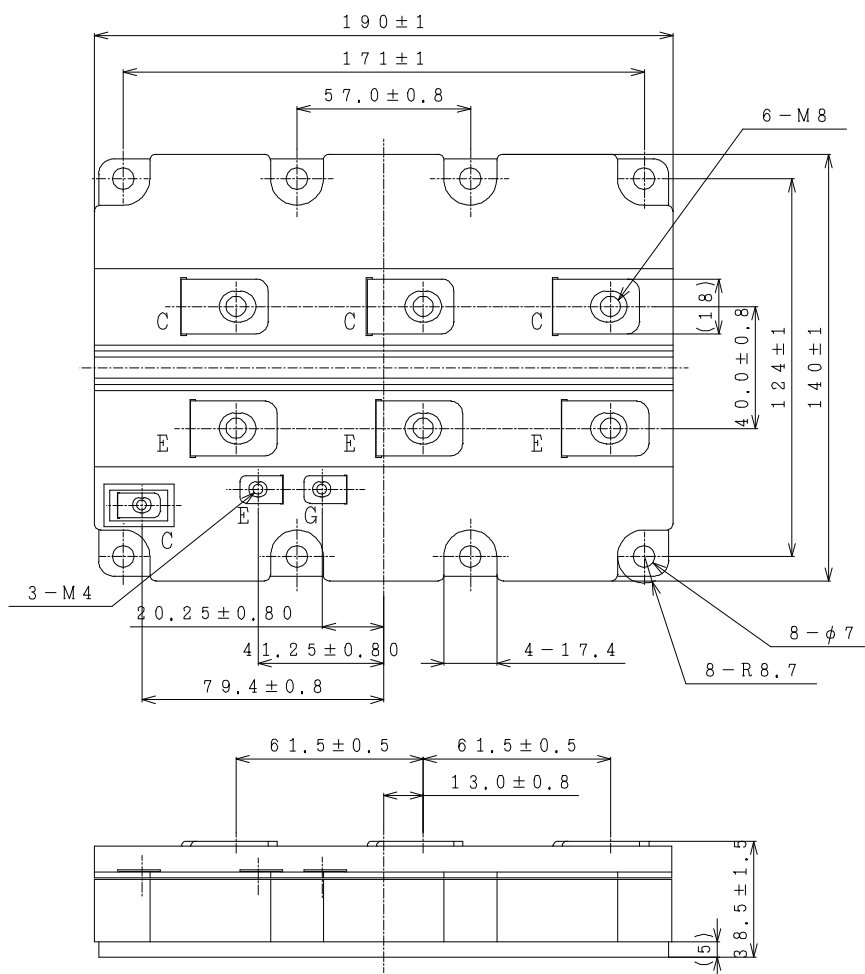
Target Specification



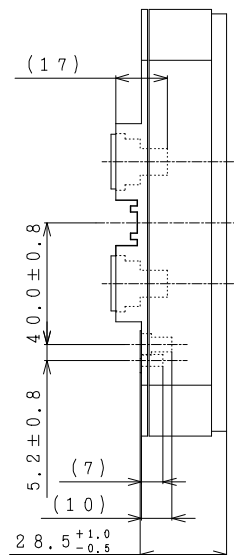
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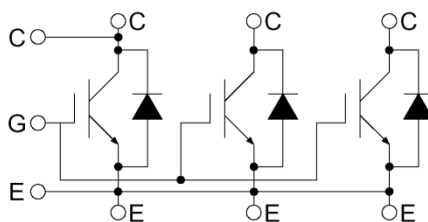
Outline Drawing



Unit in mm



Weight: 1300g

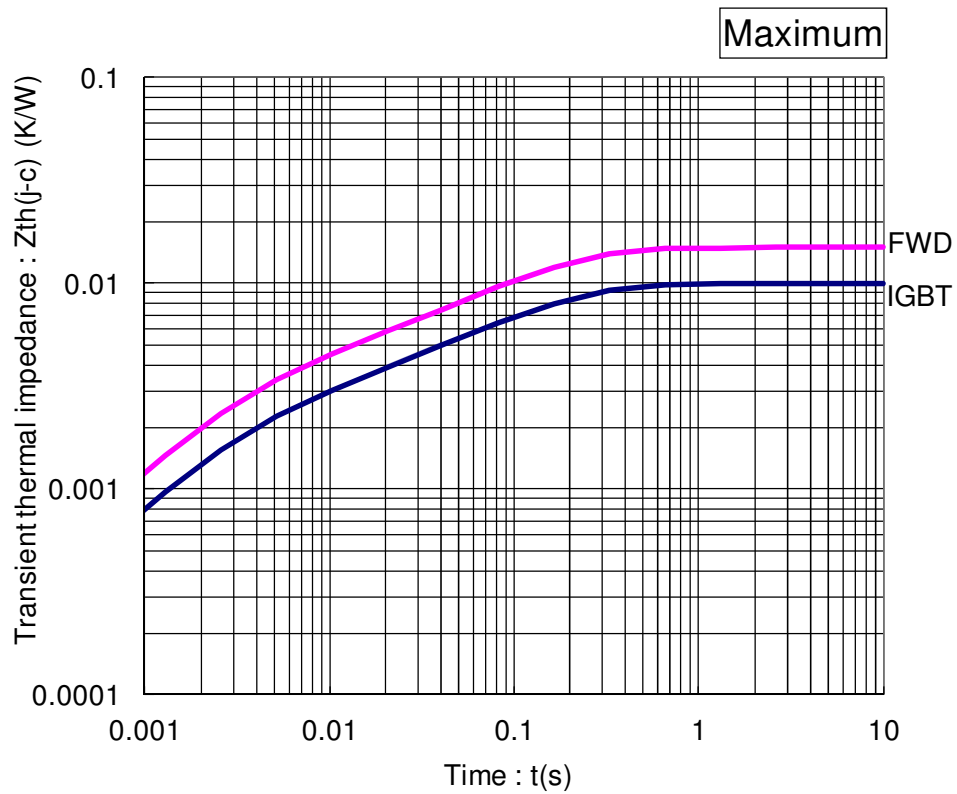


Circuit Diagram

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TRANSIENT THERMAL IMPEDANCE



Transient Thermal Impedance Curve

Curve approximation model

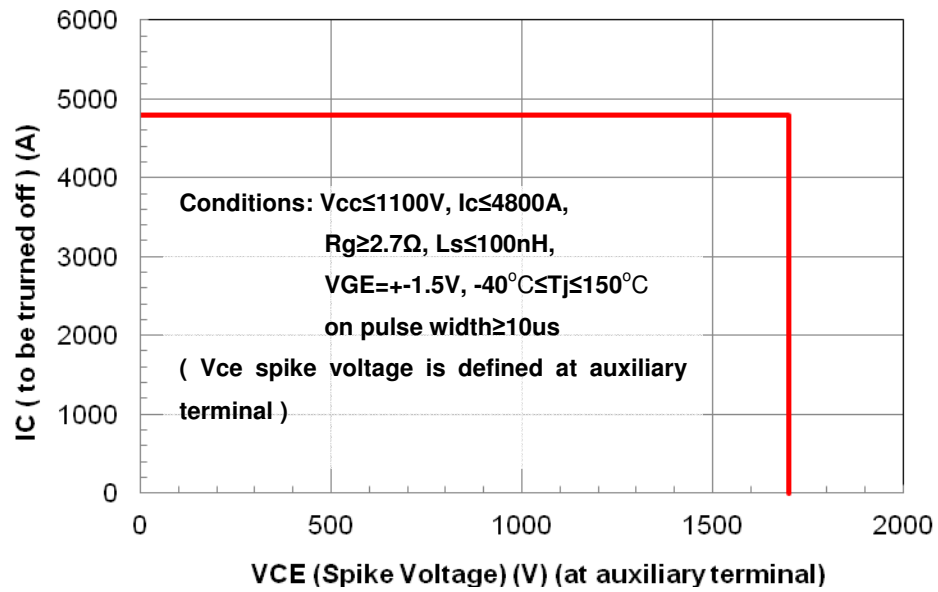
$$(\sum Z_{th}[n] * (1 - \exp(-t/\tau_{th}[n])))$$

n	1	2	3	4	5	6	7	Unit
$\tau_{th}[n]$	0.30	0.10	0.03	0.01	0.003	0.001	0.0003	sec
Zth[n,IGBT]	1.625E-03	5.328E-03	1.284E-04	1.218E-03	1.323E-03	3.071E-04	6.996E-05	K/W
Zth[n,Diode]	2.400E-03	8.082E-03	1.077E-04	1.881E-03	1.953E-03	4.723E-04	1.047E-04	K/W

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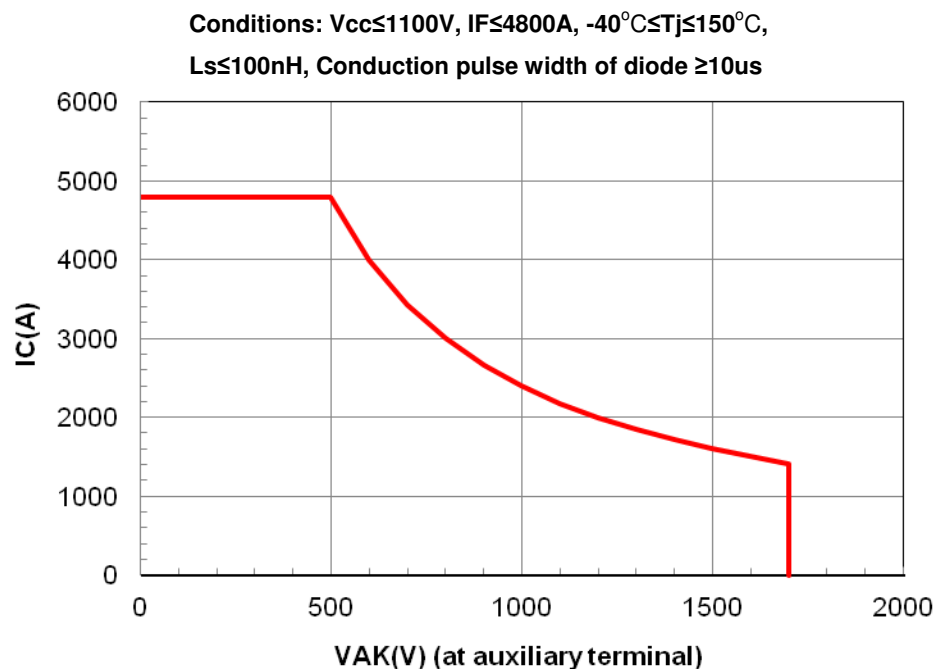
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RBSOA



Reverse bias safe operation area (RBSOA)

Recovery SOA

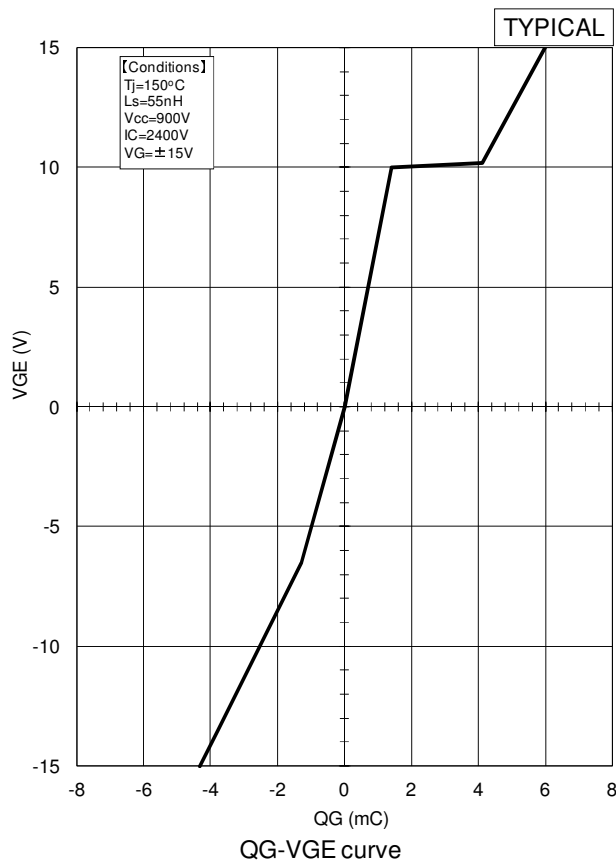


Recovery SOA

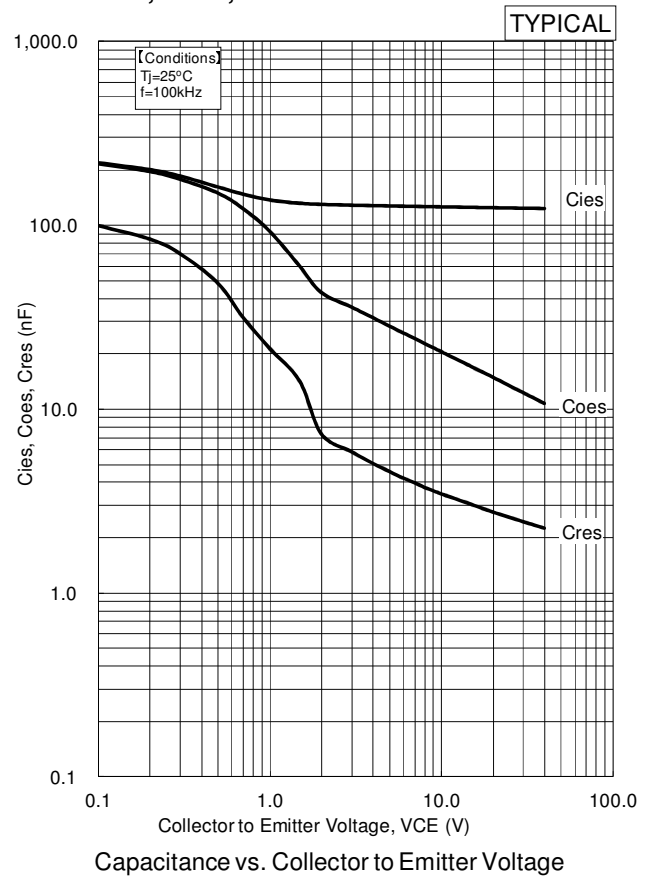
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Qg-Vg curve



Cies, Coes, Cres Curve



Material declaration

Please note the following materials are contained in the product, in order to keep characteristic and reliability level.

Material	Contained part
Lead (Pb) and its compounds	Solder

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Target Specification

HITACHI POWER SEMICONDUCTORS

Notices

1. The information given herein, including the specifications and dimensions, is subject to change without prior notice to improve product characteristics. Before ordering, purchasers are advised to contact Hitachi sales department for the latest version of this data sheets.
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